

37 CFR 1.501  
INFORMATION DISCLOSURE STATEMENT  
IN A PATENT  
(use several sheets if necessary)

Docket No.  
112740-353

Serial No.

Applicant:  
Jurisch et al.

Filing Date

Group Art Unit

### U.S. PATENT DOCUMENTS

Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If appropriate
<i>CSJ</i>	AA	5,729,465	3-17-98	Barbaresco			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

### FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
<i>CSJ</i>	AL	DE 42 05 300		Germany				
<i>CSJ</i>	AM	DE 42 11 946		Germany				
	AN							
	AO							
	AP							
	AQ							
	AR							
	AS							

### OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>CSJ</i>	AV	XP-000978300 A Recursive Least Error Squares Algorithm for Power System Relaying and Measurement Applications, Sachdev et al., pages 1008-1015
<i>CSJ</i>	AW	Lexikon Mef-und Automatisierungstechnik
<i>CSJ</i>	AX	Digitale Schutztechnik, Hermann
<i>CSJ</i>	AY	Echtzeitprozeßmodelle auf der Basis von Parameterschatzverfahren, Wede et al.

Examiner

Date Considered

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

46

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Sheet 2 of 2

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	AP							
	AQ							
	AR							
	AS							

**OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

CS	AV1	Digitale Impedanzmessverfahren Auf Der Basis Von Identifikationsmethoden
	AW	
	AX	
	AY	

Examiner: *CS*

Date Considered: 7/27/03

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